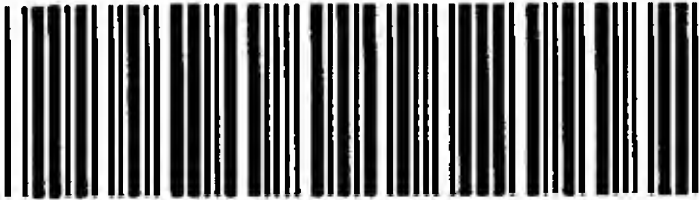


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/649,755	GUICHARD ET AL.	
	Examiner	Art Unit	
	Ellen C. Tran	2134	

SEARCHED			
Class	Subclass	Date	Examiner
726	15	2/15/2007	ECT
726	2	2/15/2007	ECT
713	153	2/15/2007	ECT
713	160	2/15/2007	ECT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	2/15/2007	ECT
INVENTOR SEARCH - PALM	2/15/2007	ECT
NPL - IEEE XPLORE	2/15/2007	ECT
All claims were reviewed for possible 101 rejection	2/15/2007	ECT